No. of Printed Pages : 2

**BIELE-002** 

## B.Tech. – VIEP – ELECTRONICS AND COMMUNICATION ENGINEERING (BTECVI)

## **Term-End Examination**

00303

## **June, 2018**

## **BIELE-002 : MICROELECTRONICS TECHNOLOGY**

1ime : 3 nour
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Maximum Marks : 70

Note: Attempt any seven questions. All questions carry equal marks. Assume suitable missing data, if any. Use of scientific calculator is permitted.

1.	Expla proce	ain with ss for crys	suitable tal growt	diagram, h.	the	float-zone	10
2.	Discuss the following :						5+5
	(a)	Defects in	n real cry	stal			
	(b)	Range th	eory of io	n-implanta	ation		
3.	Describe kinetics of silicon dioxide growth and its orientation dependent effects.						

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BIELE-002
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4.	State	the diffusion equation	and	explain	the					
	follow	wing: $4 \times 2\frac{1}{2} = 10$								
	(a)	Lateral diffusion effect								
	(b)	Sheet resistance								
	(c)	Surface concentration								
5.	What	Vhat is etching? Discuss plasma etching process.								
	How	s it different from wet etc	hing ?	2.	+6+2=10					
6.	Write notes on :									
	(a)	a) Photo Reactive Materials								
	(b)	Properties of Silicon Diox	tide							
7.	Expla	Explain the steps involved in the integration of								
	bipolar junction transistor process. 10									
8.	. Explain the steps involved in NMOS fabrication									
	with s	uitable diagram.			10					
9.	(a)	What is E-beam lithograp	ohy?		5+5					
	(b)	What are the orient	ation	depend	ent					
		properties of silicon ?								
10.	Discus	s the following :			5+5					
	(a)	a) Multi-level Metallization Process								
	(b)	RIE Techniques								